

March 2013

FDP032N08

N-Channel PowerTrench[®] MOSFET 75 V, 235 A, 3.2 m Ω

Features

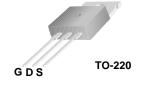
- $R_{DS(on)}$ = 2.5 m Ω (Typ.)@ V_{GS} = 10 V, I_D = 75 A
- · Fast Switching Speed
- · Low Gate Charge
- High Performance Trench Technology for Extremely Low $R_{\text{DS}(\text{on})}$
- High Power and Current Handling Capability
- · RoHS Compliant

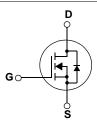
Description

This N-Channel MOSFET is produced using Fairchild Semiconductor[®]'s adcanced PowerTrench[®] process that has been tailored to minimize the on-state resistance while maintaining superior switching performance.

Applications

- Synchronous Rectification for ATX / Server / Telecom PSU
- · Battery Protection Circuit
- Motor Drives and Uninterruptible Power Supplies





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted*

Symbol			FDP032N08	Unit	
V _{DSS}	Drain to Source Voltage			75	V
V _{GSS}	Gate to Source Voltage	Gate to Source Voltage			V
	Drain Current - Co	ontinuous (T _C = 25°C, Silicon Limited)		235*	Α
I _D	- Continuous (T _C = 100°C, Silicon Limited)			165*	Α
	- Co	ontinuous (T _C = 25°C, Package Limite	ed)	120	Α
I _{DM}	Drain Current	(Note 1)	940	Α	
E _{AS}	Single Pulsed Avalanche Energy (Note 2)		(Note 2)	1995	mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	6.0	V/ns
n	Davier Diagination	$(T_C = 25^{\circ}C)$		375	W
P_{D}	Power Dissipation	- Derate above 25°C		2.5	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range			-55 to +175	°C
T _L	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds				

Thermal Characteristics

Symbol	Parameter	FDP032N08	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max. 0.4		
$R_{\theta CS}$	Thermal Resistance, Case to Sink Typ. 0.5		°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max. 62.5		

Package Marking and Ordering Information $T_C = 25^{\circ}C$ unless otherwise noted

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDP032N08	FDP032N08	TO-220	-	-	50

Electrical Characteristics

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Charac	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V, T_C = 25^{\circ} C$	75	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D = 250\mu\text{A}$, Referenced to 25°C	-	0.05	-	V/°C
1	Zero Gate Voltage Drain Current	$V_{DS} = 75V, V_{GS} = 0V$	-	-	1	
IDSS	Zero Gate voltage Drain Current	$V_{DS} = 75V, T_{C} = 150^{\circ}C$	-	-	500	μA
I _{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	±100	nA

On Characteristics

V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	2.5	3.5	4.5	V
R _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 75A$	-	2.5	3.2	mΩ
g _{FS}	Forward Transconductance	$V_{DS} = 10V, I_{D} = 75A$	-	180	-	S

Dynamic Characteristics

C _{iss}	Input Capacitance	$V_{DS} = 25V, V_{GS} = 0V$ f = 1MHz		11400	15160	pF
C _{oss}	Output Capacitance			1360	1810	pF
C _{rss}	Reverse Transfer Capacitance			595	800	pF
Q _{g(tot)}	Total Gate Charge at 10V		-	169	220	nC
Q_{gs}	Gate to Source Gate Charge	$V_{DS} = 60V, I_{D} = 75A$	-	60	-	nC
Q_{gd}	Gate to Drain "Miller" Charge	$V_{GS} = 10V$ (Note 4)	-	47	-	nC

Switching Characteristics

t _{d(on)}	Turn-On Delay Time		-	230	470	ns
t _r		$V_{DD} = 37.5V, I_D = 75A$	-	191	392	ns
t _{d(off)}	Turn-Off Delay Time	$R_{GEN} = 25\Omega$, $V_{GS} = 10V$	-	335	680	ns
t _f	Turn-Off Fall Time	(Note 4)	-	121	252	ns

Drain-Source Diode Characteristics

I _S	Maximum Continuous Drain to Source Diode Forward Current			-	235	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	940	Α
V_{SD}	Drain to Source Diode Forward Voltage V _{GS} = 0V, I _{SD} = 75A		-	-	1.3	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0V, I _{SD} = 75A	-	53	-	ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$	-	77	-	nC

Notes:

- Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L = 0.71mH, I_{AS} = 75A, V_{DD} = 50V, R_{G} = 25 $\!\Omega$, Starting T_{J} = 25 $^{\circ}C$
- 3. $I_{SD} \le 75 A$, di/dt $\le 200 A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$
- 4. Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

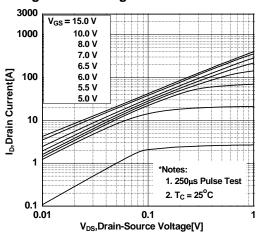


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

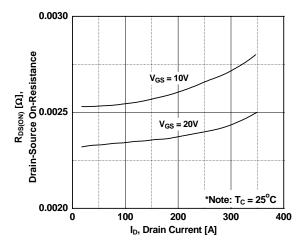


Figure 5. Capacitance Characteristics

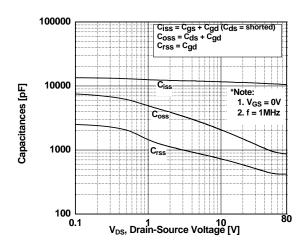


Figure 2. Transfer Characteristics

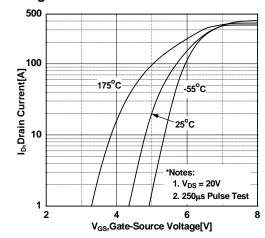


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

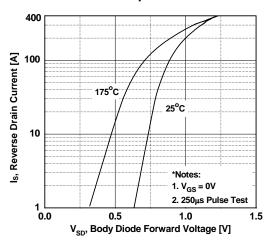
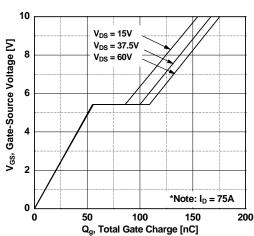


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

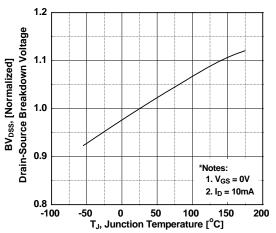


Figure 9. Maximum Safe Operating Area

3.0

2.5

0.0

0.5

0.5

1.0

0.5

1. Voss = 10V

2. l_p = 75A

0

Figure 8. On-Resistance Variation vs.

Temperature

Figure 10. Maximum Drain Current vs. Case Temperature

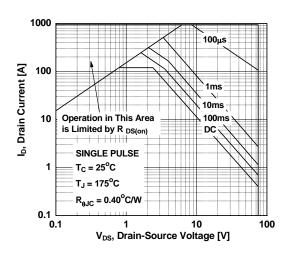
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T_J, Junction Temperature [°C]

100

150

200



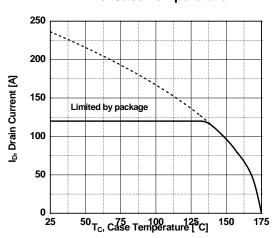
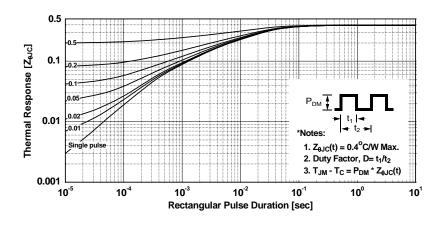
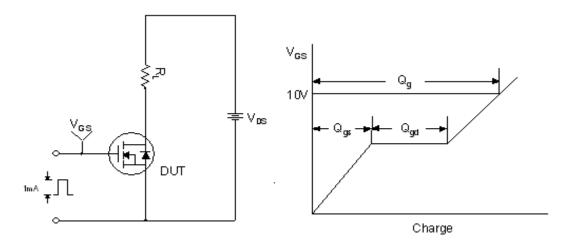


Figure 11. Transient Thermal Response Curve

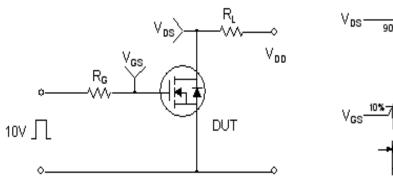
-100

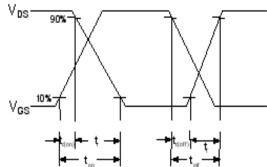


Gate Charge Test Circuit & Waveform

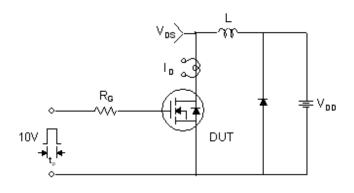


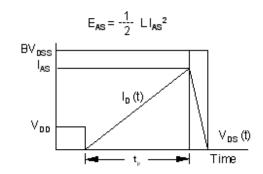
Resistive Switching Test Circuit & Waveforms



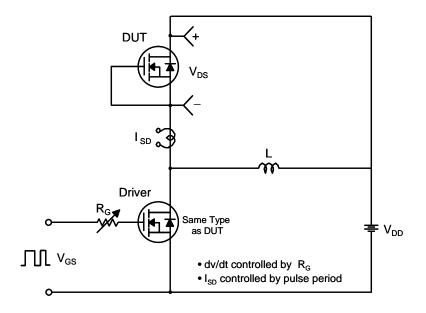


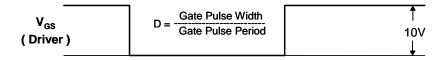
Unclamped Inductive Switching Test Circuit & Waveforms

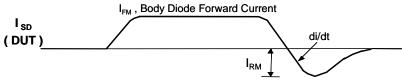




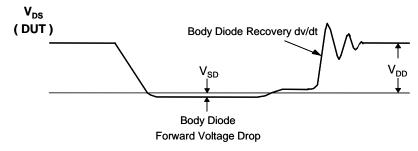
Peak Diode Recovery dv/dt Test Circuit & Waveforms





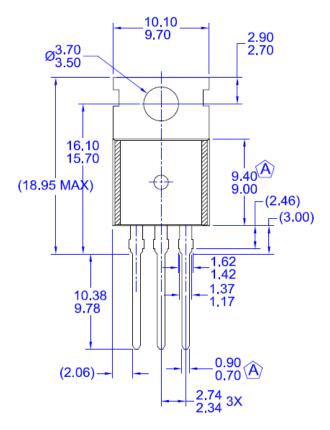


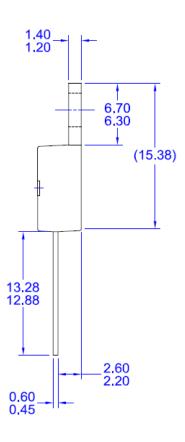
Body Diode Reverse Current

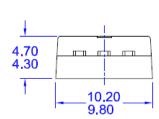


Mechanical Dimensions

TO-220Y03







NOTES:

- (A) CONFORMS TO JEDEC TO-220 VARIATION AB EXCEPT WHERE NOTED
- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- D) DRAWING FILE/REVISION: MKT-TO220Y03REV1

Dimensions in Millimeters





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